

P-Channel 20 V (D-S) MOSFET

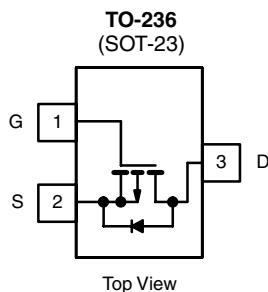
PRODUCT SUMMARY			
V_{DS} (V)	$R_{DS(on)}$ (Ω)	I_D (A) ^a	Q_g (Typ.)
- 20	0.061 at $V_{GS} = - 4.5$ V	- 4.4	7.6 nC
	0.080 at $V_{GS} = - 2.5$ V	- 3.8	
	0.110 at $V_{GS} = - 1.8$ V	- 3.3	
	0.165 at $V_{GS} = - 1.5$ V	- 0.5	

FEATURES

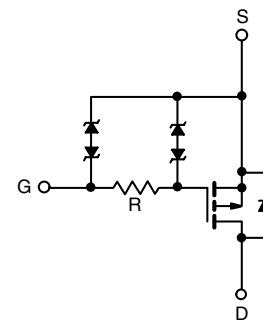
- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET® Power MOSFET
- 100 % R_g Tested
- Typical ESD Performance 2000 V
- Built in ESD Protection with Zener Diode
- Compliant to RoHS Directive 2002/95/EC



RoHS
COMPLIANT
HALOGEN
FREE



Si2377EDS (P6)*
* Marking Code



P-Channel MOSFET

Ordering Information: Si2377EDS-T1-GE3 (Lead (Pb)-free and Halogen-free)

ABSOLUTE MAXIMUM RATINGS $T_A = 25$ °C, unless otherwise noted				
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V_{DS}	- 20	V	
Gate-Source Voltage	V_{GS}	± 8		
Continuous Drain Current ($T_J = 150$ °C)	I_D	- 4.4	A	
		- 3.5		
		- 3.7 ^{b, c}		
		- 2.9 ^{b, c}		
Pulsed Drain Current	I_{DM}	- 20		
Continuous Source-Drain Diode Current	I_S	- 1.5	W	
		- 1.0 ^{b, c}		
Maximum Power Dissipation	P_D	1.8	W	
		1.1		
		1.25 ^{b, c}		
		0.8 ^{b, c}		
Operating Junction and Storage Temperature Range	T_J, T_{stg}	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature) ^{d, e}		260		

THERMAL RESISTANCE RATINGS				
Parameter	Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^{b, d}	R_{thJA}	80	100	°C/W
Maximum Junction-to-Foot (Drain)	R_{thJF}	55	70	

Notes:

- a. $T_C = 25$ °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. $t = 5$ s.
- d. Maximum under Steady State conditions is 130 °C/W.

Si2377EDS

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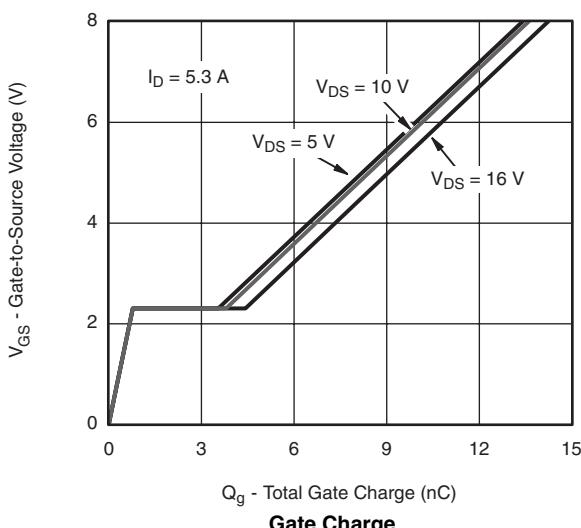
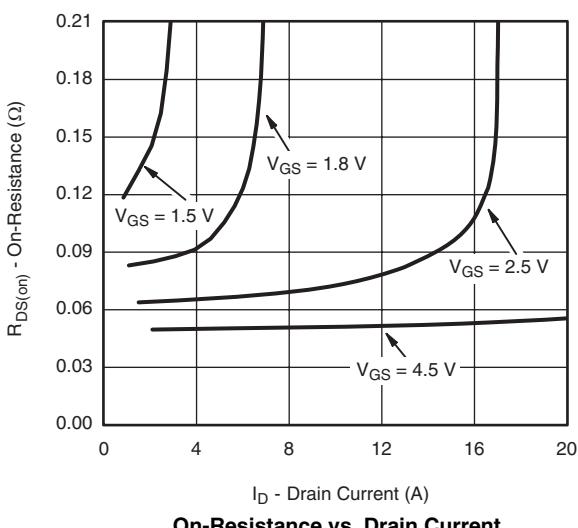
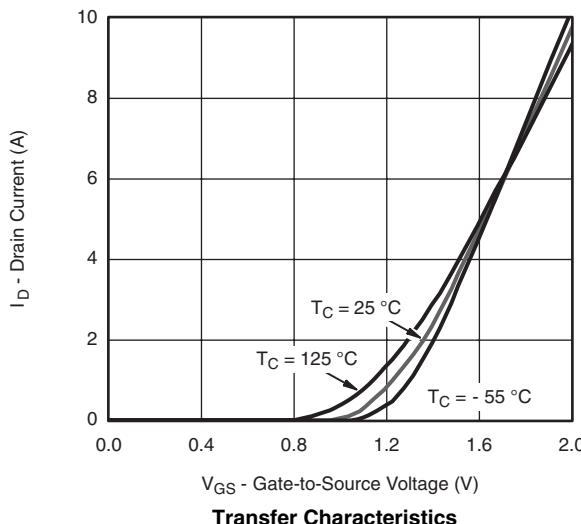
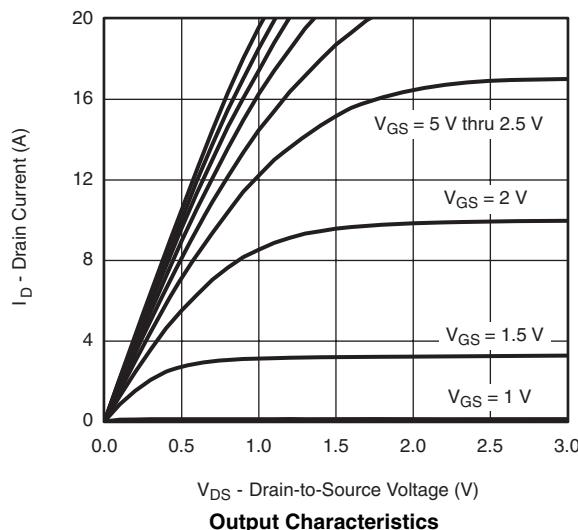
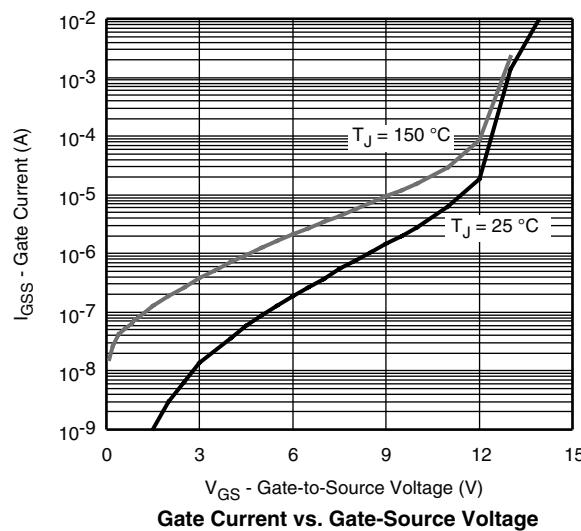
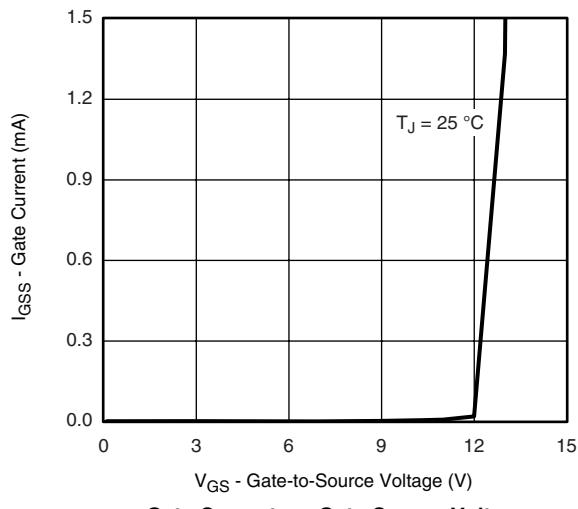
**SPECIFICATIONS** $T_J = 25^\circ\text{C}$, unless otherwise noted

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-20			V
V_{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	$I_D = -250 \mu\text{A}$		-13		mV/ $^\circ\text{C}$
$V_{GS(\text{th})}$ Temperature Coefficient	$\Delta V_{GS(\text{th})}/T_J$			2.5		
Gate-Source Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = -250 \mu\text{A}$	-0.4		-1	V
Gate-Source Leakage	I_{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$			± 6	μA
		$V_{DS} = 0 \text{ V}, V_{GS} = \pm 4.5 \text{ V}$			± 0.5	
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}$			-1	
		$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 55^\circ\text{C}$			-10	
On-State Drain Current ^a	$I_{D(\text{on})}$	$V_{DS} \leq -5 \text{ V}, V_{GS} = -4.5 \text{ V}$	-15			A
Drain-Source On-State Resistance ^a	$R_{DS(\text{on})}$	$V_{GS} = -4.5 \text{ V}, I_D = -3.2 \text{ A}$		0.050	0.061	Ω
		$V_{GS} = -2.5 \text{ V}, I_D = -2.8 \text{ A}$		0.065	0.080	
		$V_{GS} = -1.8 \text{ V}, I_D = -1.5 \text{ A}$		0.090	0.110	
		$V_{GS} = -1.5 \text{ V}, I_D = -0.5 \text{ A}$		0.110	0.165	
Forward Transconductance ^a	g_{fs}	$V_{DS} = -10 \text{ V}, I_D = -3.2 \text{ A}$		12		S
Dynamic^b						
Total Gate Charge	Q_g	$V_{DS} = -10 \text{ V}, V_{GS} = -8 \text{ V}, I_D = -5.3 \text{ A}$		14	21	nC
Gate-Source Charge	Q_{gs}	$V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V}, I_D = -5.3 \text{ A}$		7.6	12	
				0.8		
Gate-Drain Charge	Q_{gd}			3.1		
Gate Resistance	R_g	$f = 1 \text{ MHz}$	0.4	2	4	k Ω
Turn-On Delay Time	$t_{d(\text{on})}$	$V_{DD} = -10 \text{ V}, R_L = 2.3 \Omega$ $I_D \geq -4.3 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$		0.20	0.3	μs
Rise Time	t_r			1.00	1.50	
Turn-Off Delay Time	$t_{d(\text{off})}$			4.00	6.00	
Fall Time	t_f			2.00	3.00	
Turn-On Delay Time	$t_{d(\text{on})}$			0.09	0.14	
Rise Time	t_r			0.40	0.60	
Turn-Off Delay Time	$t_{d(\text{off})}$			5.20	7.80	
Fall Time	t_f			2.30	3.50	
Drain-Source Body Diode Characteristics						
Continuous Source-Drain Diode Current	I_S	$T_C = 25^\circ\text{C}$			-1.5	A
Pulse Diode Forward Current	I_{SM}				-20	
Body Diode Voltage	V_{SD}	$I_S = -3 \text{ A}, V_{GS} = 0 \text{ V}$		-0.8	-1.2	V
Body Diode Reverse Recovery Time	t_{rr}	$I_F = -3 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}, T_J = 25^\circ\text{C}$		30	60	ns
Body Diode Reverse Recovery Charge	Q_{rr}			20	40	nC
Reverse Recovery Fall Time	t_a			13		ns
Reverse Recovery Rise Time	t_b			17		

Notes:

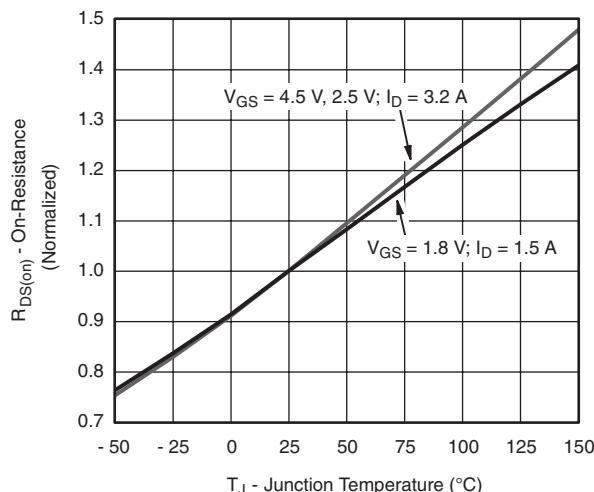
- a. Pulse test; pulse width $\leq 300 \mu\text{s}$, duty cycle $\leq 2\%$.
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

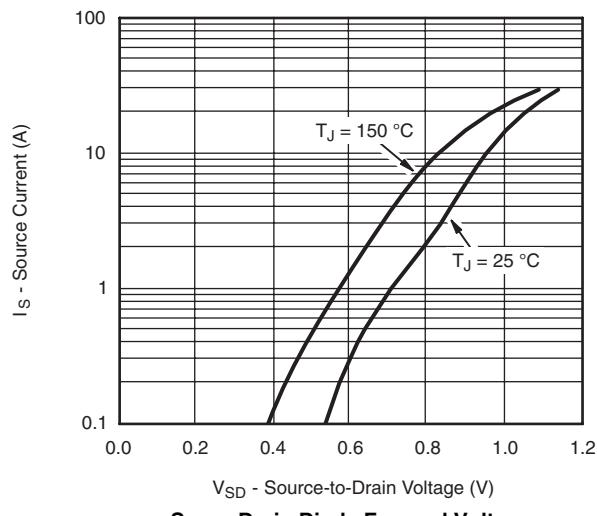
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

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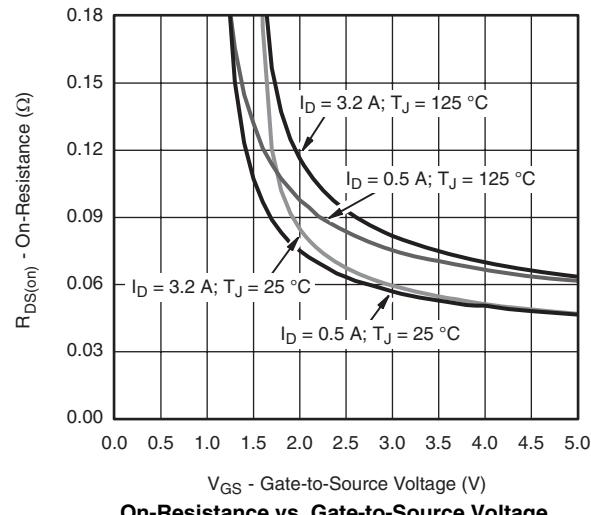
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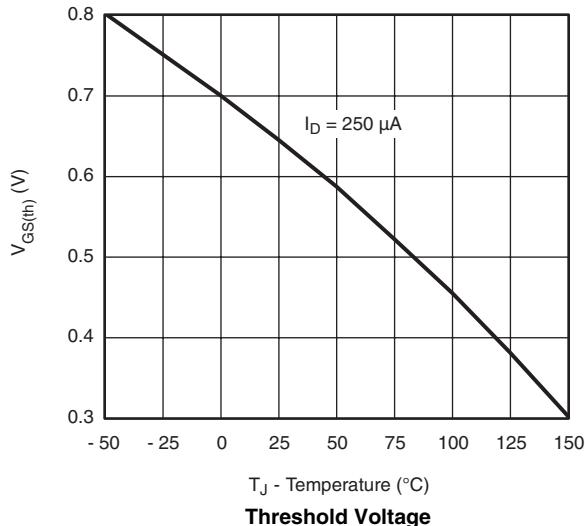
On-Resistance vs. Junction Temperature



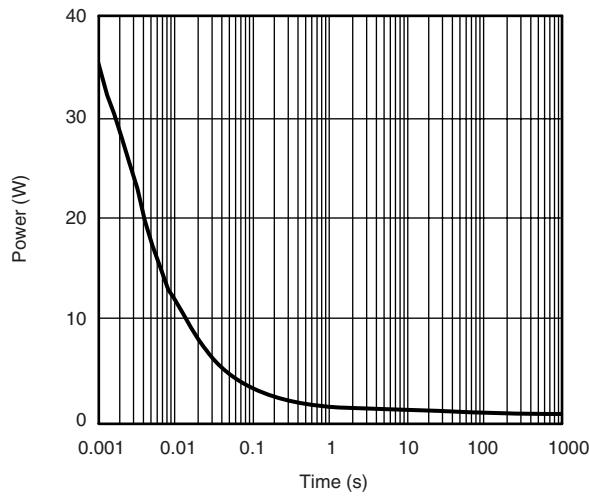
Source-Drain Diode Forward Voltage



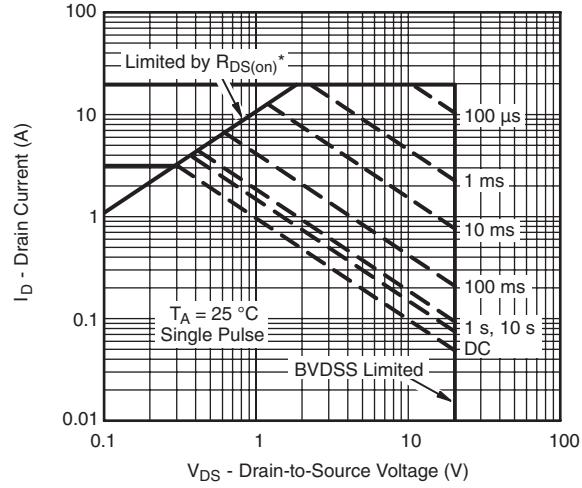
On-Resistance vs. Gate-to-Source Voltage



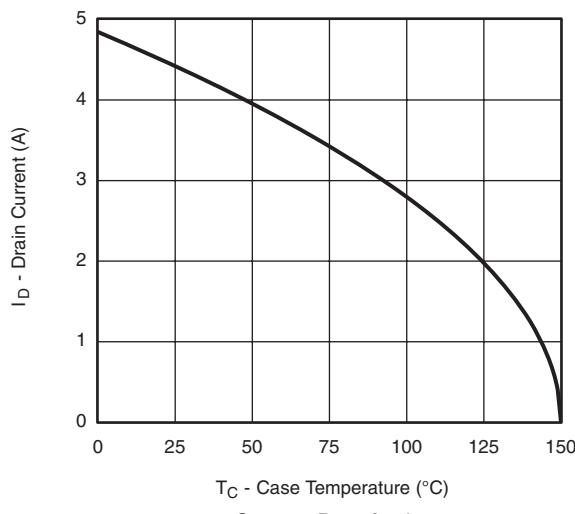
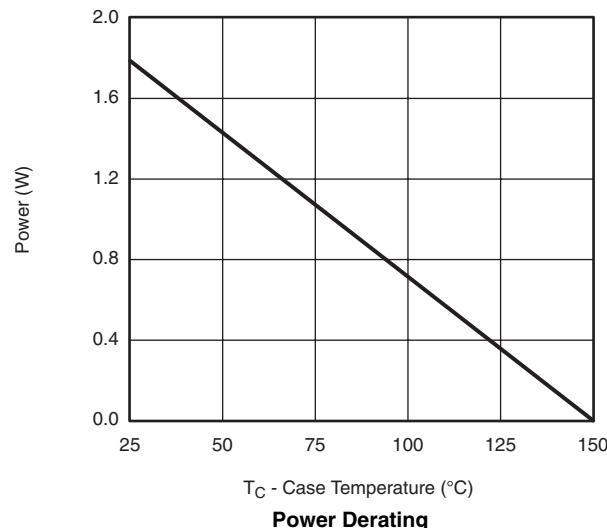
Threshold Voltage



Single Pulse Power, Junction-to-Ambient

* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

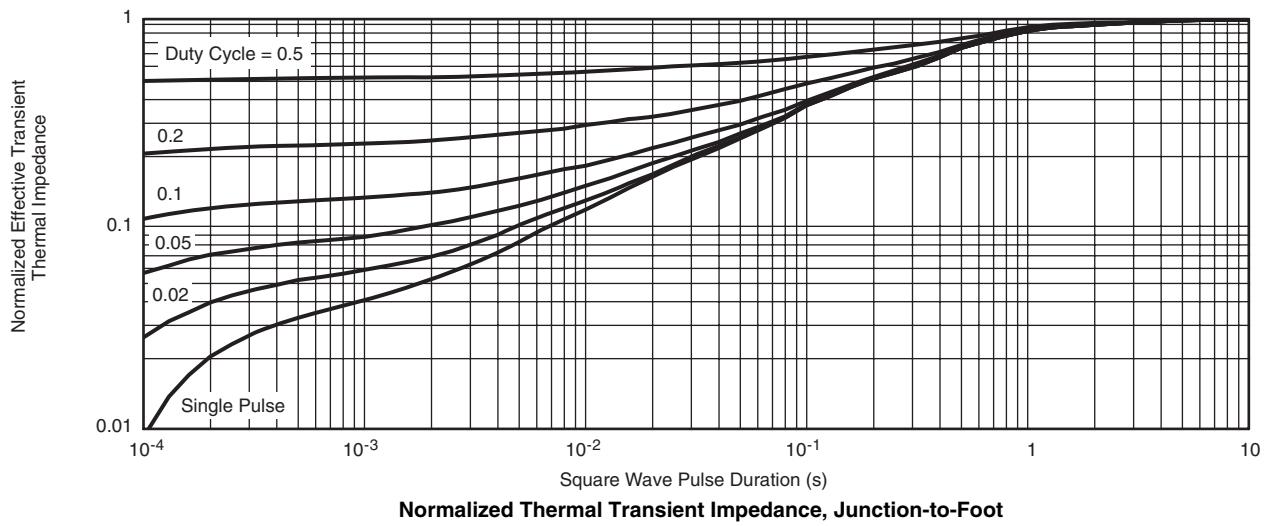
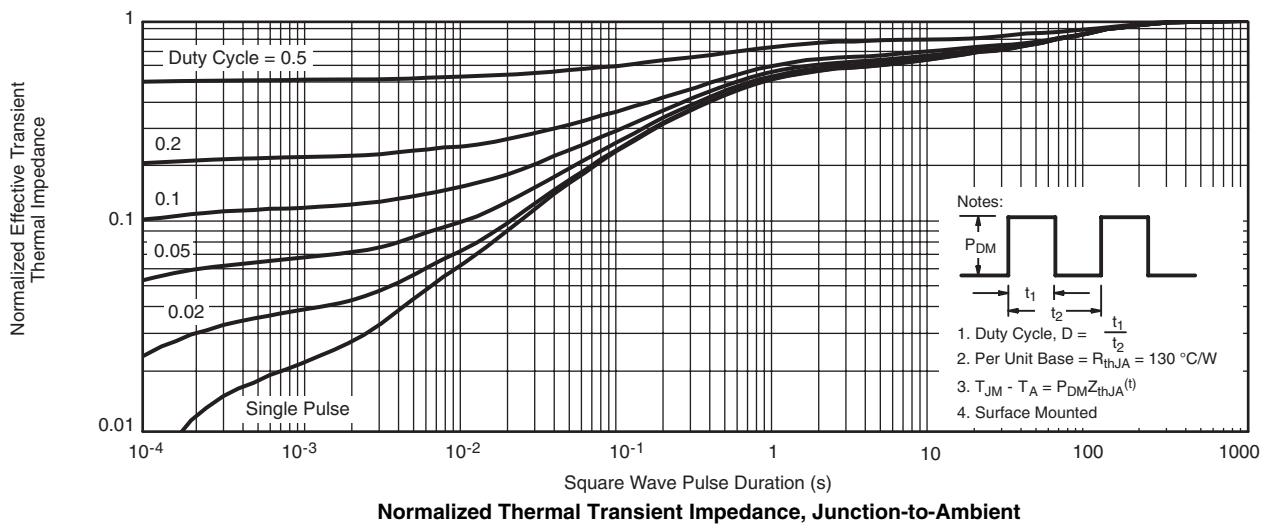
Safe Operating Area, Junction-to-Ambient

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted**Current Derating*****Power Derating**

* The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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